



Technical Report

To : To Whom it may concern

CC : Kang SungYoul(Danny) (US XDCR CD-TRE TDS MPE), Rumwell, Reginald (SHS US XDCR DC-

TRE), Kim, GiSeok (US XDCR CD-TRE TDS MPE)

From: Park, SoYun(US XDCR CD-TRE TDS MPE)

Date: Mar 15th, 2021

Title: materials compatibility test with Perform.

■ Executive Summary:

This report is to qualify the material compatibility of 4V1c, 5C1, 10L4, 14L5, 18L6, 4Z1c, 8C3HD, 14L5SP, 10MC3, EC9-4, V5Ms and Z6Ms transducers with Perform. All transducers have been tested and determined to be compatible with this disinfectant except for 10L4, 4Z1c and Z6Ms. These three transducers are not compatible with this disinfectant. This report will be a justification to update compatible disinfectants in the Transducer Disinfectant Compatibility Matrix (P/N 11335653).

■ Scope:

• Test protocol: Transducer Disinfectant Qualification Process (P/N 5931980)

5.2.1 Liquid Extended Exposure Protocol (soak transducers for 168 hours at 30°C)

• Pass/Fail Criteria: Transducer Disinfectant Qualification Process (P/N 5931980)

Disinfectant

Perform used in the testing is a powder type, the disinfection powder is diluted with water to the desired concentration for use. The manufacture which called Schulke confirmed that the spectrum of efficacy / reprocessing level depends on the concentration of the use solution. Please refer to the Attachment 1.

The material compatibility test was carried out at 2% solution. For this reason, Perform is classified as HLD in this report. Please see below for detailed ingredient information.

Use solution of Perform	Reprocessing Level
0.5%	LLD
1%	LLD
2%	HLD

Ingredient information

	Reprocessing level	Active ingredient	CAS No	Concentration
Perform	HLD	Pentapotassium bis(peroxymonosulphate) bis(sulphate)	70693-62-8	45%
		Anionic surfactants	-	5-15%
		Non-ionic surfactants		<5%

Tested transducers and the results

• rested transducers an	Tested transducers and the results										
Transducers	P/N	AAAAAS/N	Transducers family	Test results							
4V1c MP2	07695724	20160450	A2	PASS							
5C1 TC-ZIF	11268278	20220296	A3	PASS							
10L4 MP456	10787114	20210535	A4	Fail							
14L5 MP456	11254090	21010221	A5	PASS							
18L6 MP456	10787113	21080257	A6	PASS							
4Z1c MP2	10789391	20130044	A7	Fail							



8C3HD MP2	10135943	21070497	A9	PASS
14L5SP MP2	10041226	21080039	S1	PASS
10MC3 DL260 & TC-ZIF	11268679	20060694	E1	PASS
EC9-4 DL260 & TC-ZIF	10789383	20220122	E2	PASS
V5Ms	11013704	21060007	T3	PASS
Z6Ms	10436113	83534016	T5	Fail

These transducers are the representative of each transducer family group. Therefore, the group members can be covered by results of representatives. Following table shows the transducer family as Transducer Family Classification for Reprocessing (P/N 11508294).

Transducers	P/N	Family
4V1c MP2 (representative)	07695724	
8V3 MP1.5	10789382	A2
8V3 MP456	11014578	
5C1 MP456 (representative)	11291794	
4V1 MP456	11014576	
CH5-2 DL260	08648086/ 10789386	
CH5-2 TC-ZIF	10136141	
5C1 TC-ZIF	11268278	
7C2 TC-ZIF	11268277	
16L4 TC-ZIF	11284846	
8V4 TC-ZIF	11284847	A3
5P1 TC-ZIF	11014154	AS
P8-4 DL260 & TC-ZIF	10030615/ 10789389 & 11014543	
P4-2 DL260 & TC-ZIF	08648045/ 10789385 & 10136143	
13L4 TC-ZIF	11361589	
DAX MP456	10787116	
5V1 MP456	11291796	
VF16-5 DL260	10785041	
VF16-5 TC-ZIF	11014552	
10L4 MP456 (representative)	10787114	
VF10-5 DL260 & TC-ZIF	08648110/ 10789387 & 10136142	A4
11L4 DL260 & TC-ZIF	11361584 & 11284844	44
9L4 MP2	10035946 / 10789393	
14L5 MP456 (representative)	11254090	
10V4 MP1 & TC-ZIF & MP456	08266709 &11319697 & 11014579	
4P1 MP2	10041224/ 10789398	A5
VF13-5 TC-ZIF	10789372	
14L5 MP2.0	10041221/ 10789396	
18L6 MP456 (representative)	10787113	
VF12-4 DL260	10136922	
12L4 MP2	10786035	
6C1HD MP2	10135941	A6
12L3 TC-ZIF	11268279	
18L6HD MP2	10041227/ 10789400	
9C3 MP456	10787112	
4Z1c MP2 (representative)	10033682/ 10789391	A7
8C3HD MP2 (representative)	10135943	
18L6HD MP2	10041227/ 10789400	A9
6C1HD MP2	10135941	
14L5SP MP2 (representative)	10041226	S1
VF13-5 SP DL 360	08266907	



10MC3 (representative)	11284842 & 11268679	E1
EC9-4 (representative)	8648029/ 10789383 & 10136144	E2
V5Ms (representative)	11013704	ТЗ
5VT TC-ZIF	11370949	13
Z6Ms (representative)	10436113	T5

■ Summary of the test result

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XDCR name	XDCR S/N	Section		Before soaking	After soaking	Diff(After-Before)	Result
		Hip	ot test	0.207 mA	0.177 mA	-	Pass
		Leak	age test	12.794 uA	11.510 uA	-	Pass
			Sens.std at 4.0MHz	0.42 dB	0.43 dB	0.01 dB	Pass
4V1c	20160450	Probe	Sens.std at 3.0MHz	0.29 dB	0.3 dB	0.01 dB	Pass
4010	20160450	element test	Sens.std at 1.5MHz	0.45 dB	0.48 dB	0.03 dB	Pass
			TOF	7.65 ns	5.2 ns	2.45 ns	Pass
			Dead element	0	0	0	Pass
		Cosmetic Inspection		No defect	No defect		Pass

XDCR name	XDCR S/N	Section		Before soaking	After soaking	Diff(After-Before)	Result
		Hip	ot test	0.242 mA	0.216 mA	-	Pass
		Leak	age test	15.395 uA	14.060 uA		Pass
			Sens.std at 4.0MHz	0.81 dB	0.75 dB	0.06 dB	Pass
		Probe	Sens.std at 3.0MHz	0.55 dB	0.49 dB	0.06 dB	Pass
5C1	20220296	element 0296 test	Sens.std at 1.8MHz	0.41 dB	0.32 dB	0.09 dB	Pass
	20220200		TOF	6.4 ns	4.8 ns	1.6 ns	Pass
			Dead element	0	1	1	Pass
		Cosmetic Inspection		No defect	No defect	-	Pass
		Final decision		Pass, there was a single dead element. But it is considered that the dead element was not caused by disinfectant. Because there was no sensitivity degradation.			

XDCR name	XDCR S/N	Section		Before soaking	After soaking	Diff(After-Before)	Result
		Hip	ot test	0.250 mA	0.213 mA	-	Pass
		Leak	age test	14.855 uA	13.928 uA	-	Pass
			Sens.std at 6.0MHz	0.53 dB	0.66 dB	0.13 dB	Pass
		Probe element test	Sens.std at 8.0MHz	0.63 dB	0.63 dB	0 dB	Pass
10L4	20210535		Sens.std at 4.0MHz	0.37 dB	0.43 dB	0.06 dB	Pass
			TOF	3.75 ns	5.31 ns	1.56 ns	Pass
			Dead element	0	0	0	Pass
		Cosmetic Inspection		No defect	bubbles on the lens surface	-	Fail
		Final decision			Fail		

XDCR name	XDCR S/N	Section		Before soaking	After soaking	Diff(After-Before)	Result
		Hip	ot test	0.152 mA	0.175 mA	-	Pass
		Leak	age test	10.272 uA	10.885 uA	-	Pass
			Sens.std at 8.5MHz	0.44 dB	1.1 dB	0.66 dB	Pass
		Probe	Sens.std at 10.5MHz	0.54 dB	1.15 dB	0.61 dB	Pass
14L5	21010221	21010221 element test	Sens.std at 6.0MHz	0.49 dB	0.55 dB	0.06 dB	Pass
			TOF	2.88 ns	5.63 ns	2.75 ns	Pass
			Dead element	0	0	0	Pass
		Cosmetic Inspection		No defect	No defect	-	Pass

XDCR name	XDCR S/N	Section		Before soaking	After soaking	Diff(After-Before)	Result
		Hip	ot test	0.213 mA	0.248 mA	-	Pass
		Leak	age test	13.114 uA	15.001 uA	-	Pass
			Sens.std at 10.0MHz	0.64 dB	0.64 dB	0 dB	Pass
18L6	21080257	Probe element test	Sens.std at 12.0MHz	0.63 dB	0.66 dB	0.03 dB	Pass
1010	21000237		Sens.std at 8.0MHz	0.59 dB	0.66 dB	0.07 dB	Pass
			TOF	3.31 ns	6.79 ns	3.48 ns	Pass
			Dead element	1	1	0	Pass
		Cosmetic Inspection		No defect	No defect	-	Pass

XDCR name	XDCR S/N	Section		Before soaking	After soaking	Diff(After-Before)	Result
		Hip	ot test	0.363 mA	0.385 mA	-	Pass
		Leak	age test	24.854 uA	26.332 uA	-	Fail
			Sens.std at 1.2MHz	0.19 V/V	0.22 V/V	1.273381597 dB	Pass
4Z1c	20130044	Probe element	Sens.std at 3.0MHz	0.15 V/V	0.17 V/V	1.087153246 dB	Pass
42.10	20130044	test	TOF	9.7 ns	9.5 ns	0.2 ns	Pass
			Dead element	20	20	0	Pass
		Cosmetic Inspection		No defect	No defect	-	Pass
		Final decision		Fail, 4Z1c failed the leakage test, but this sample already had a high result of leakage test before test. So we have to do retest with good condition sample.			

XDCR name	XDCR S/N	Se	ection	Before soaking	After soaking	Diff(After-Before)	Result	
		Hip	ot test	0.253 mA	0.313 mA	-	Pass	
		Leak	age test	15.898 uA	18.920 uA	-	Pass	
	:		Sens.std at 6.0MHz	0.58 dB	0.59 dB	0.01 dB	Pass	
		Probe element test		Sens.std at 3.5MHz	0.41 dB	0.44 dB	0.03 dB	Pass
8C3HD	21070497			Sens.std at 8.0MHz	0.59 dB	0.6 dB	0.01 dB	Pass
			TOF	4.55 ns	3.97 ns	0.58 ns	Pass	
		Dead element	0	0	0	Pass		
		Cosmetic	c Inspection	No defect	No defect	-	Pass	



XDCR name	XDCR S/N	Se	ection	Before soaking	After soaking	Diff(After-Before)	Result		
		Hip	ot test	0.142 mA	0.172 mA	-	Pass		
		Leak	age test	8.759 uA	9.874 uA	-	Pass		
			Sens.std at 8.5MHz	0.45 dB	0.59 dB	0.14 dB	Pass		
14L5SP	21090020	21080039	Sens.std at 10.5MHz	0.56 dB	0.73 dB	0.17 dB	Pass		
141.558	21000039				Sens.std at 6.0MHz	0.46 dB	0.51 dB	0.05 dB	Pass
	:		TOF	7.01 ns	3.77 ns	3.24 ns	Pass		
			Dead element	0	0	0	Pass		
		Cosmeti	c Inspection	No defect	No defect	-	Pass		

XDCR name	XDCR S/N	Se	ection	Before soaking	After soaking	Diff(After-Before)	Result	
		Hip	ot test	0.227 mA	0.208 mA	-	Pass	
		Leak	age test	14.126 uA	13.753 uA	-	Pass	
			Sens.std at 6.5MHz	0.4 dB	0.59 dB	0.19 dB	Pass	
400400	20000004	694 Probe at	element	Sens.std at 5.0MHz	0.4 dB	0.7 dB	0.3 dB	Pass
10MC3	20060694			Sens.std at 8.0MHz	0.68 dB	1.34 dB	0.66 dB	Pass
			TOF	6.4 ns	8.77 ns	2.37 ns	Pass	
			Dead element	0	0	0	Pass	
		Cosmeti	c Inspection	No defect	No defect	-	Pass	

XDCR name	XDCR S/N	Se	ection	Before soaking	After soaking	Diff(After-Before)	Result
		Hip	ot test	0.233 mA	0.222 mA		Pass
		Leak	age test	14.420 uA	14.013 uA	-	Pass
			Sens.std at 6.5MHz	0.73 dB	0.49 dB	0.24 dB	Pass
EC9-4	20220122	Probe	Sens.std at 4.0MHz	0.66 dB	0.54 dB	0.12 dB	Pass
EU9-4	20220122	element test	Sens.std at 8.0MHz	0.9 dB	0.59 dB	0.31 dB	Pass
		Dead	TOF	5.87 ns	5.43 ns	0.44 ns	Pass
			Dead element	0	0	0	Pass
		Cosmetic	Inspection	No defect	No defect	-	Pass

XDCR name	XDCR S/N	Section		Before soaking	After soaking	Diff(After-Before)	Result	
			Hipot tes	t	3.97 mA	4.96 mA	-	Pass
			Leakage te	est	247.362 uA	298.852 uA	-	Pass
		Sens	Sens	at 7MHz	1 dB	0.8 dB	0.2 dB	Pass
V5Ms	21060007	Probe	Stdev	at 5MHz	0.97 dB	0.9 dB	0.07 dB	Pass
VOIVIS	21000007	element	at 0 deg	at 3.5MHz	1.44 dB	1.2 dB	0.24 dB	Pass
		test	-	TOF	3.6 nS	3.6 nS	0.0 ns	Pass
			Dead		0	0	0	Pass
		С	osmetic Insp	ection	No defect	No defect	-	Pass

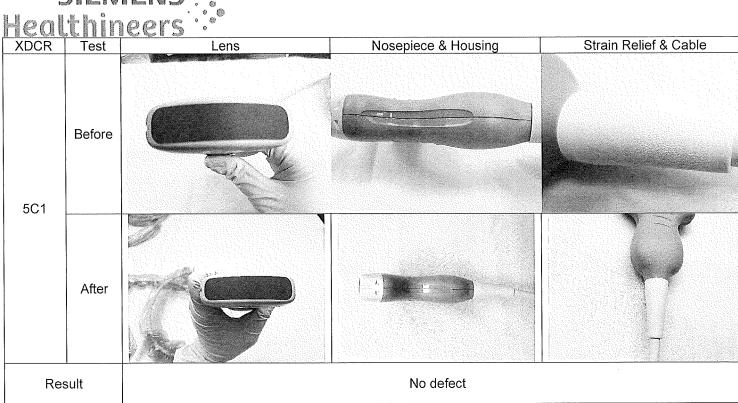


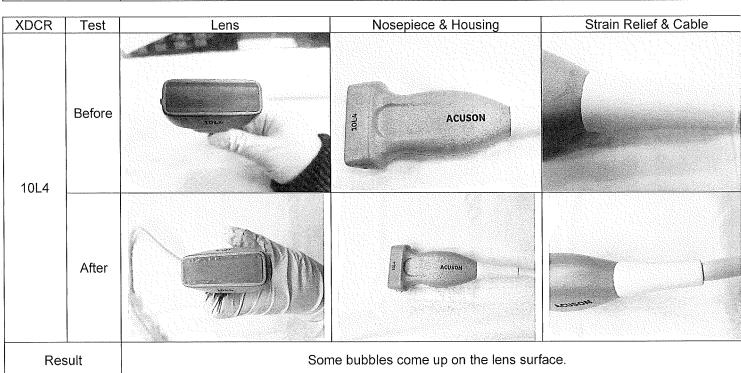
XDCR name	XDCR S/N		ection	Before soaking	After soaking	Diff(After-Before)	Result
		Hipot test		4.49 mA	4.5 mA	-	Pass
		Leak	age test	276.431 uA	274.966 uA	-	Pass
			Sensitivity Stdevat 3MHz	0.17 V/V	0.18 V/V	0.496471675 dB	Pass
7014-	00504046	Probe	Sensitivity Stdevat 5MHz	0.15 V/V	0.16 V/V	0.560574472 dB	Pass
Z6Ms	83534016	element test	Sensitivity Stdevat 6MHz	0.11 V/V	0.12 V/V	0.755771218 dB	Pass
			TOF	8.6 ns	8.2 ns	0.4 ns	Pass
			Dead element	6	40	34	Fail
	Cosmeti	c Inspection	No defect	No defect	-	Pass	
1		Final	decision		Fai	l	

■ Cosmetic inspection

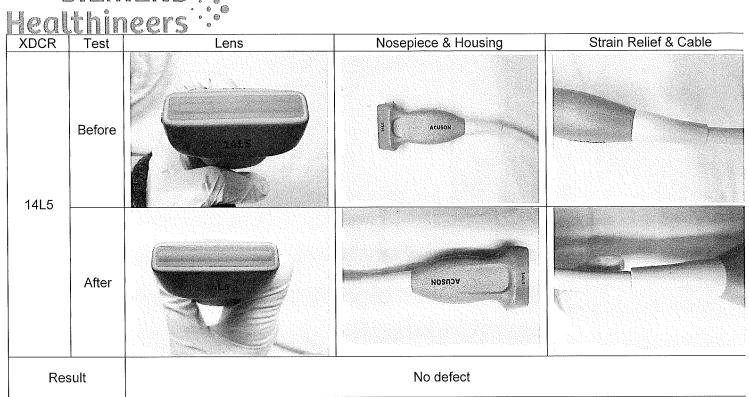
XDCR	Test	Lens	Nosepiece & Housing	Strain Relief & Cable
4V1c	Before	AVI6 Print		
4010	After			
Res	sult		No defect	





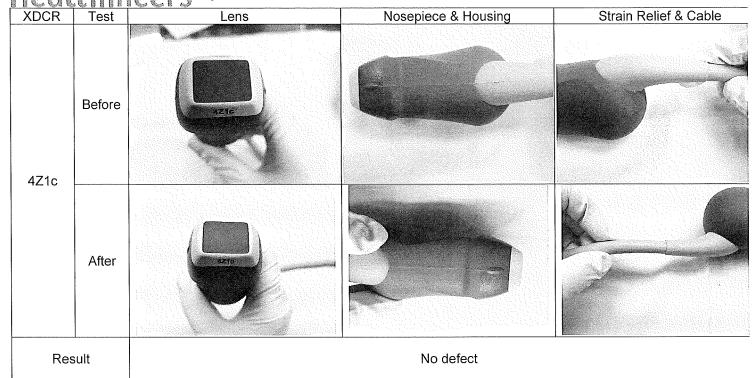


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XDCR	Test	Lens	Nosepiece & Housing	Strain Relief & Cable
18L6	Before	9788	Nosav la	
1810	After		ACUSON	
Re	sult		No defect	

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XDCR	Test	Lens	Nosepiece & Housing	Strain Relief & Cable
8C3HD	Before			
003i ib	After			
Res	ult		No defect	



XDCR	Test	Lens	Nosepiece & Housing	Strain Relief & Cable
14L5SP	Before		M559	
112001	After			
Resu	ult		No defect	

XDCR	Test	Lens	Nosepiece & Housing	Strain Relief & Cable
10MC3	Before			10MC3
	After			JOMES
Res	ult		No defect	



XDCR	Test	Lens	Nosepiece & Housing	Strain Relief & Cable
EC9-4	Before			
	After			
Res	ult		No defect	

XDCR	Test	Lens & Articulation	Guide tube	Overall
V5Ms	Before			
	After		100	
Result		No defect		



XDCR	Test	Lens & Articulation	Guide tube	Overall
Z6MS	Before			NET ASSET.
	After			
Result		No defect		

■ Conclusion:

As this result, Perform is approved to use on 4V1c, 5C1, 14L5, 18L6, 8C3HD, 14L5SP, EC9-4, 10MC3 and V5Ms. Moreover, Each transducers in transducer groups of A2, A3, A5, A6, A9, S1, E1, E2 and T3 can also be used in this disinfectant wipes. 10L4, 4Z1c and Z6Ms are not compatible with these disinfectants. These results will be updated in Transducer Disinfectant Compatibility Matrix (P/N 11335653).

Test Procedure

- 1) Test protocol: Transducer Disinfectant Qualification Process (P/N 5931980)
 - 5.2.1 Liquid Extended Exposure Protocol (soak transducers for 168 hours at 30°C)
- 2) Pass/Fail Criteria: Transducer Disinfectant Qualification Process (P/N 5931980)
 In order for a disinfectant to be qualified for use with a particular transducer group, the long-term soak and cyclic disinfection exposures:
 - 1) Must not cause the test transducer to fail hipot or leakage current tests.
 - 2) Must not cause the relative sensitivity standard deviation to increase by more than 2 dB (array transducers only).
 - 3) Must not cause the time of flight (TOF) standard deviation to increase by more than 5nS (array transducers only).
 - 4) Must not cause a significant increase in the number of dead elements, as judged by engineering (single or small groups of dead elements may be due to other causes).
 - 5) Must not cause mechanical degradation related to transducer performance in the form of cracking, micro-crazing, swelling, corrosion, separation on all the surfaces that cleaner/disinfectant



6) May occur discoloration of acoustic lens or other materials as this is not related to transducer performance.

Since only safety tests and visual inspection are performed on mechanical and CW transducers, these must be inspected with particular care for signs of physical deterioration.

If a transducer fails any of the above criteria, it will be inspected by Engineering to determine the cause of failure. If the failure appears to be related to a manufacturing defect, or other issue not caused by the disinfection exposure, a second transducer of the same type will be tested to confirm the result.

■ Related Document

Transducer Cleaner Disinfectant Qualification Process, P/N 5931980 The Transducer Disinfectant Compatibility Matrix, P/N 11335653 Cleaner & Disinfectant Family Classification, P/N 11508294 Transducer Family Classification for Reprocessing, P/N 11508925

Attachment

1) Technical data sheet of Perform

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2020.08.14 MSDS Perform Info.pdf AW_ Introductions perform.pdf and more help near

2) Test results

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XDCR name	XDCR S/N	Test	Probe acoustic Test	Hipot & Leakage Test
4V1c	20160450	Pre-test	x2ng4.impulse.ana x2ng4.impulse.eva lysis.production.pol.production.post_c	SCM FAO-01 Station.Engineering
		Post-test	x2ng4.impulse.ana x2ng4.impulse.eva lysis.development.pl.development.post	SCM FAO-01 Station.Engineering
5C1	20220296	Pre-test	x2ng4.impulse.ana x2ng4.impulse.eva lysis.production.pol.production.post_c	SCM FAO-01 Station.Engineering
		Post-test	x2ng4.impulse.ana x2ng4.impulse.eva lysis.development.pl.development.post	SCM FAO-01 Station.Engineering
10L4	20210535	Pre-test	x2ng5.impulse.ana x2ng5.impulse.eva lysis.development.pl.development.posi	SCM FAO-01 Station.Engineering

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		Post-test	x2ng5.impulse.ana x2ng5.impulse.eva lysis.development.tl.development.post	SCM FAO-01 Station.Engineering
14L5	21010221	Pre-test	x2ng5.impulse.ana x2ng5.impulse.eva lysis.production.pol.production.post_c	SCM FAO-01 Station.Production
		Post-test	x2ng5.impulse.ana x2ng5.impulse.eva lysis.development.fl.development.post	SCM FAO-01 Station.Engineering
	21080257	Pre-test	x2ng5.impulse.ana x2ng5.impulse.eva lysis.production.pol.production.post_c	SCM FAO-01 Station.Production
18L6		Post-test	x2ng5.impulse.ana x2ng5.impulse.eva lysis.development.post	SCM FAO-01 Station.Production
474	20130044	Pre-test	PE test_4Z1c Perform Before_21	Hipot&Leakage test_4Z1c Perform
4Z1c		Post-test	PE test_4Z1c Perform After_210:	SCM FAO-01 Station.Production
000110	21070497	Pre-test	x2ng5.impulse.ana x2ng5.impulse.eva lysis.production.pol.production.post_c	SCM FAO-01 Station.Production
8C3HD		Post-test	x2ng5.impulse.ana x2ng5.impulse.eva lysis.development.pl.development.post	SCM FAO-01 Station.Production
14L5CD	21080039	Pre-test	x2ng5.impulse.ana x2ng5.impulse.eva lysis.production.pol.production.post_c	SCM FAO-01 Station.Production
14L5SP		Post-test	x2ng5.impulse.ana x2ng5.impulse.eva lysis.development.post	SCM FAO-01 Station.Production
10MC3	20060694	Pre-test	x2ng4.impulse.analysix2ng4.impulse.eval.pr s.production.post_caboduction.post_cable.1	SCM FAO-01 Station.Production.FA(

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		Post-test	x2ng4.impulse.analysi x2ng4.impulse.eval.d s.development.post_cevelopment.post_cabl	SCM FAO-01 Station.Engineering.F/
EC9-4 V5Ms	20220122	Pre-test	x2ng4.impulse.ana x2ng4.impulse.eva lysis.production.pol.production.post_c	SCM FAO-01 Station.Engineering
		Post-test	x2ng4.impulse.ana x2ng4.impulse.eva lysis.development.pl.development.post	SCM FAO-01 Station.Engineering
		Pre-test	xdcrii2.impulse.an xdcrii2.impulse.eva alysis.production.pl.production.pre_ca	SCM TEE-01 Station.Production
		Post-test	xdcrii2 V5Ms 210308 SN2106007	SCM TEE-01 Station.Engineering
Z6Ms	83534016	Pre-test	PE test_Z6Ms (SN 83534016).pdf	Hipot&leakage test_Z6Ms (SN 865
		Post-test	sc2000.trb200.mix = 1.prod.pn = 10436	SCM TEE-01 Station.Production